## $\square$ MN101C54A , MN101C54C

| Type | MN101C54A | MN101C54C |
| :---: | :---: | :---: |
| ROM (x8-bit) | 32 K | 48 K |
| RAM (x8-bit) | 2 K | 2 K |
| Package | QFP084-P-1818E *Lead-free, LQFP080-P-1414A *Lead-free, TQFP080-P-1212D *Lead-free (under planning) |  |
| Minimum Instruction Execution Time | $\begin{aligned} & 0.1 \mu \mathrm{~s} \text { (at } 4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, 20 \mathrm{MHz} \text { ) } \\ & 0.25 \mu \mathrm{~s}(\text { at } 2.7 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, 8 \mathrm{MHz})^{* 1} \\ & 62.5 \mu \mathrm{~s} \text { (at } 2.0 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, 32 \mathrm{kHz})^{* 1,2} \end{aligned}$ <br> *1 The lower limit for operation guarantee for flash memory built-in type is 4.5 V . <br> *2 The lower limit for operation guarantee for EPROM built-in type is 2.3 V . |  |
| Interrupts | -RESET • Watchdog •External 0 •External $1 \cdot$ External $2 \cdot$ External 3*1 <br> - External 4 (key interrupt dedicated) •Timer 0 - Timer 1 •Timer 2 •Timer 3 •Timer 6 •Time base <br> - Timer 7 (2 systems) •Timer 8 (2 systems) • Serial 0 ( 2 systems $)$ - Serial 2 •A/D conversion finish <br> ${ }^{* 1}$ LQFP080-P-1414A,TQFP080-P-1212D: Not mounted |  |
| Timer Counter | Timer counter $0: 8$-bit $\times 1$ <br> (square-wave/8-bit PWM output, event count, generation of remote control carrier, simple pulse width measurement) (square-wave/PWM output to large current terminal P50 possible) <br> Clock source $\cdots \cdots \cdots \cdots . . . . . . . . . . .1 / 2,1 / 4$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 32,1 / 64$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input <br> Interrupt source $\qquad$ coincidence with compare register 0 |  |
|  | Timer counter 1:8-bit $\times 1$ (square-wave output, event count, synchronous output event) <br> Clock source $\qquad$ $1 / 2,1 / 8$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 8192,1 / 32768$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input <br> Interrupt source $\qquad$ coincidence with compare register 1 |  |

Timer counter 0,1 can be cascade-connected.
Timer counter 2:8-bit $\times 1$
(square-wave output, additional pulse type 10 -bit PWM output, event count, synchronous output event, simple pulse width measurement) (square-wave/PWM output to large current terminal P52 possible)
$\qquad$ $1 / 2,1 / 4$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 32,1 / 64$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input
Interrupt source $\qquad$ coincidence with compare register 2

Timer counter 3: 8-bit $\times 1$
(square-wave output, event count, generation of remote control carrier, serial 0 baud rate timer)
Clock source $\qquad$ $1 / 2,1 / 8$ of system clock frequency; $1 / 1,1 / 4,1 / 16,1 / 64,1 / 128$ of OSC oscillation clock frequency; $1 / 1$ of XI oscillation clock frequency; external clock input
Interrupt source $\qquad$ coincidence with compare register 3

Timer counter 2, 3 can be cascade-connected.
Timer counter 6:8-bit freerun timer
Clock source $\qquad$ 1/1 of system clock frequency; 1/1, 1/4096, 1/8192 of OSC oscillation clock frequency; 1/1, 1/4096, 1/8192 of XI oscillation clock frequency
Interrupt source $\qquad$ coincidence with compare register 6

## Timer counter 7 : 16 -bit $\times 1$

(square-wave output, IGBT/16-bit PWM output (cycle / duty continuous variable), event count, synchronous output evevt, pulse width measurement, input capture) (square-wave/PWM output to large current terminal P51 possible)



## Pin Assignment



LQFP080-P-1414A*Lead-free
TQFP080-P-1212D *Lead-free (under planning)

## Support Tool

| In-circuit Emulator | $\begin{aligned} & \text { PX-ICE101C / D + PX-PRB101C54-TPFP080-P-1212D-M (under planning) } \\ & \text { PX-ICE101C / D + PX-PRB101C54-QFP084-P-1818E-M } \\ & \text { PX-ICE101C / D + PX-PRB101C54-LQFP080-P-1414A-M } \end{aligned}$ |  |
| :---: | :---: | :---: |
| EPROM Built-in Type | Type | MN101CP54C |
|  | ROM ( $\times 8$-bit) | 48 K |
|  | RAM ( $\times 8$-bit) | 2 K |
|  | Minimum instruction execution time | $0.1 \mu \mathrm{~s}$ (at 4.5 V to $5.5 \mathrm{~V}, 20 \mathrm{MHz}$ ) |
|  |  | $0.25 \mu \mathrm{~s}$ (at 2.7 V to $5.5 \mathrm{~V}, 8 \mathrm{MHz}$ ) |
|  |  | $62.5 \mu \mathrm{~s} \text { (at } 2.3 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, 32 \mathrm{kHz} \text { ) }$ |
|  | Package | LQFP080-P-1414A *Lead-free, QFP084-P-1818E *Lead-free, |
|  |  | TQFP080-P-1212D *Lead-free (under planning) |
| Flash Memory Built-in Type | Type | MN101CF54D [ES (Engineering Sample) available] |
|  | ROM ( $\times 8$-bit) | 64 K |
|  | RAM ( $\times 8$-bit) | 2 K |
|  | Minimum instruction execution time | $0.1 \mu \mathrm{~s}$ (at 4.5 V to $5.5 \mathrm{~V}, 20 \mathrm{MHz}$ ) |
|  |  | $0.25 \mu \mathrm{~s}$ (at 4.5 V to $5.5 \mathrm{~V}, 8 \mathrm{MHz}$ ) |
|  |  | $62.5 \mu \mathrm{~s}$ (at 4.5 V to $5.5 \mathrm{~V}, 32 \mathrm{kHz}$ ) |
|  | Package | LQFP080-P-1414A *Lead-free, QFP084-P-1818E *Lead-free, TQFP080-P-1212D *Lead-free (under planning) |

MN101C54A , MN101C54C $\square$

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